## Notic of Referenc s Cited Application/Control No. Applicant(s)/Patent Under Reexamination IMAI, SHINICHI Examiner Art Unit Page 1 of 1

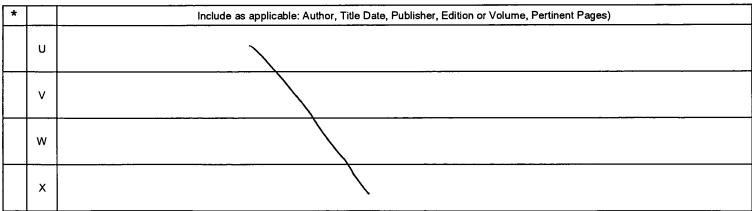
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## **NON-PATENT DOCUMENTS**



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